

### **GREENWAL**

Practice concentratea

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HOWARD J. GREENWALD

November 6, 2002

Subject:

Information Disclosure Statement

Application:

Group Art Unit: 2872

U.S.S.N.:

10/077.922

Filing Date:

February 19, 2002

Attorney Docket: BTI-18

**Enclosures:** 

Information Disclosure Statement Patent Documents

Information Disclosure Statement Non-Patent Literature

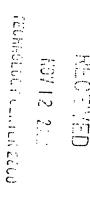
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Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it displays a valid OMB control number. BADENA **Application Number** 10/077.922 **TRANSMITTAL** February 19, 2002 💭 **Filing Date FORM** Stuart G. MacDonald **First Named Inventor** Group Art Unit (to be used for all correspondence after initial filing) 2872 **Examiner Name BTI-18** Total Number of Pages in This Submission Attorney Docket Number **ENCLOSURES** (check all that apply) After Allowance Communication Assignment Papers Fee Transmittal Form to Group (for an Application) Appeal Communication to Board Fee Attached Drawing(s) of Appeals and Interferences Appeal Communication to Group Licensing-related Papers Amendment/Reply (Appeal Notice, Brief, Reply Brief) Petition After Final Proprietary Information ' Petition to Convert to a Provisional Application Affidavits/declaration(s) Status Letter Power of Attorney, Revocation Other Enclosure(s) (please Change of Correspondence Extension of Time Request Address identify below): Transmittal Form Terminal Disclaimer Transmittal of Information Disclosure Statement Express Abandonment Request Request for Refund Copy of Cited References Information Disclosure Statement CD. Number of CD(s). Return Postcard HKOLOGY CERTER Certified Copy of Priority Remarks Document(s) Response to Missing Parts/ Incomplete Application Response to Missing Parts under 37 CFR 1.52 or 1.53 SIGNATURE OF APPLICANT, ATTORNEY, OR AGENT Firm Greenwald & Basch LLP Individual name By: Duane C. Basch Signature Date CERTIFICATE OF MAILING I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to: Commissioner for Patents, Washington, DC 20231 on this date:

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### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

application of: plication No.:

10/077,922

Confirmation No: 6499 Filed:

February 19, 2002

Examiner:

Group No.: 2872

For:

**Assistant Commissioner for Patents** 

Washington, D.C. 20231

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2) The Information Disclosure Statement submitted herewith contains information that was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Information Disclosure Statement. 37 C.F.R. section 1.97 (e) (1).

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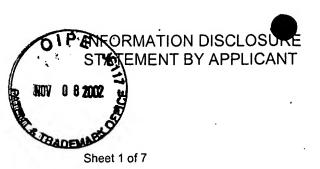
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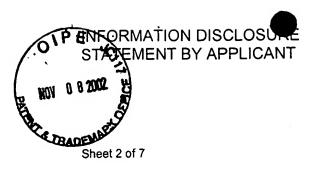
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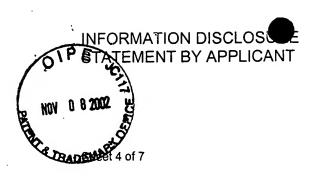
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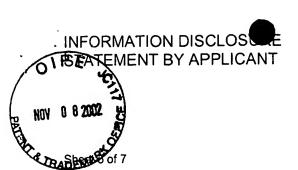
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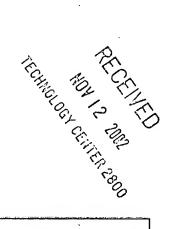
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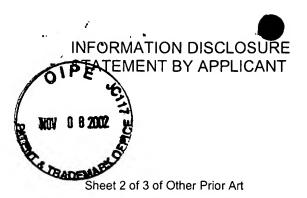


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Application Number 10/077,922
Filing Date February 19, 2002
First Named Inventor Stuart G. MacDonald
Group Art Unit 2872
Examiner Name
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